


<b>Search Notes</b>  	<b>Application/Control No.</b>  10051226	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Sheng, Tom V	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	87,92,93,103	1/19/2007, 4/23/07	TS
349	42,43,54,139,149,152,192		

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	1/19/2007, 4/23/07	TS
Inventor Search	4/23/07	TS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
345	92, 103	4/23/2007	TS
349	139		